

Fourier-Transform Infrared Spectroscopic Ellipsometry for Material Identification

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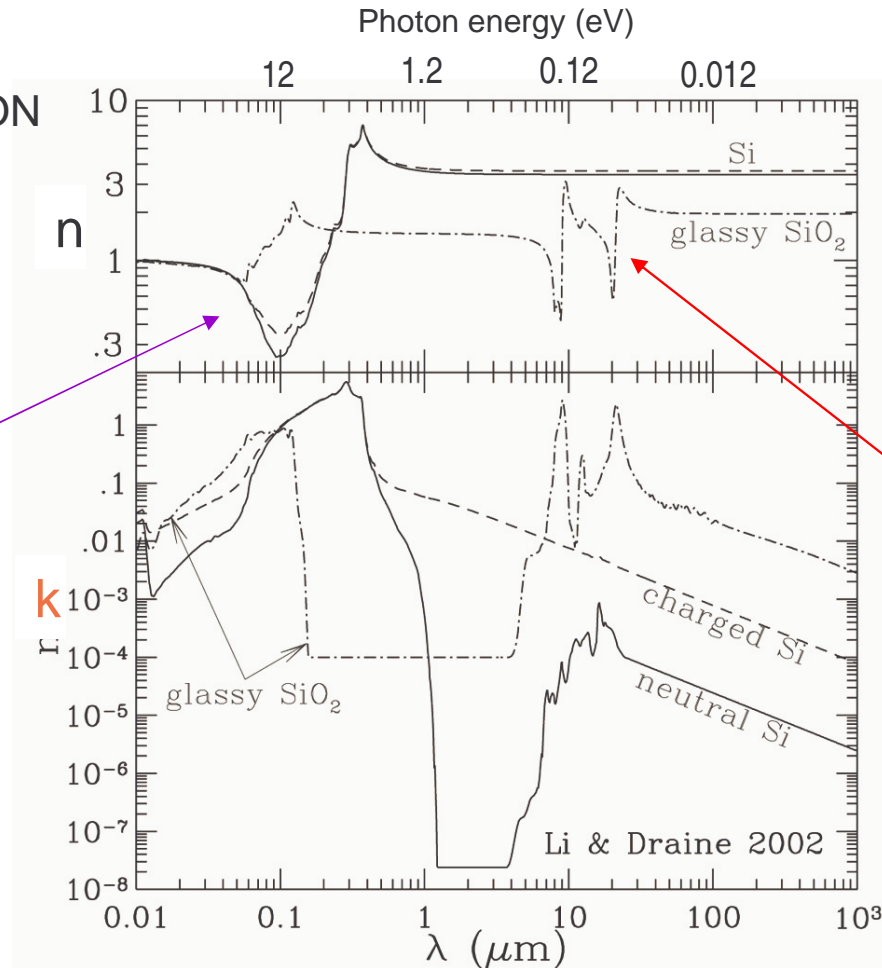
Outline of the talk

- Optical constants of solids
- Ellipsometry basics
- Fourier-transform infrared spectroscopy (FTS or FT-IR)
- Far-infrared/Terahertz setup: detectors, sources
- The case of remote identification of explosives:
 - transmission
 - reflection
 - ellipsometry

Optical constants of solids

INDEX OF REFRACTION
(COMPLEX)

Electronic
excitations
(electron-hole pairs)
(Interband transitions)



Equivalent formulations:

- Dielectric constant ϵ
- Optical conductivity σ

$$\begin{aligned}\epsilon_1 &= n^2 - k^2 \\ \epsilon_2 &= 2nk \\ \sigma_1 &= \frac{\omega}{4\pi} \epsilon_2 \\ \sigma_2 &= \frac{\omega}{4\pi} (\epsilon_\infty - \epsilon_1)\end{aligned}$$

Dipolar
Lattice
Vibrations
(optical phonons)
(normal modes)

Chemical element
identification



Chemical species
identification

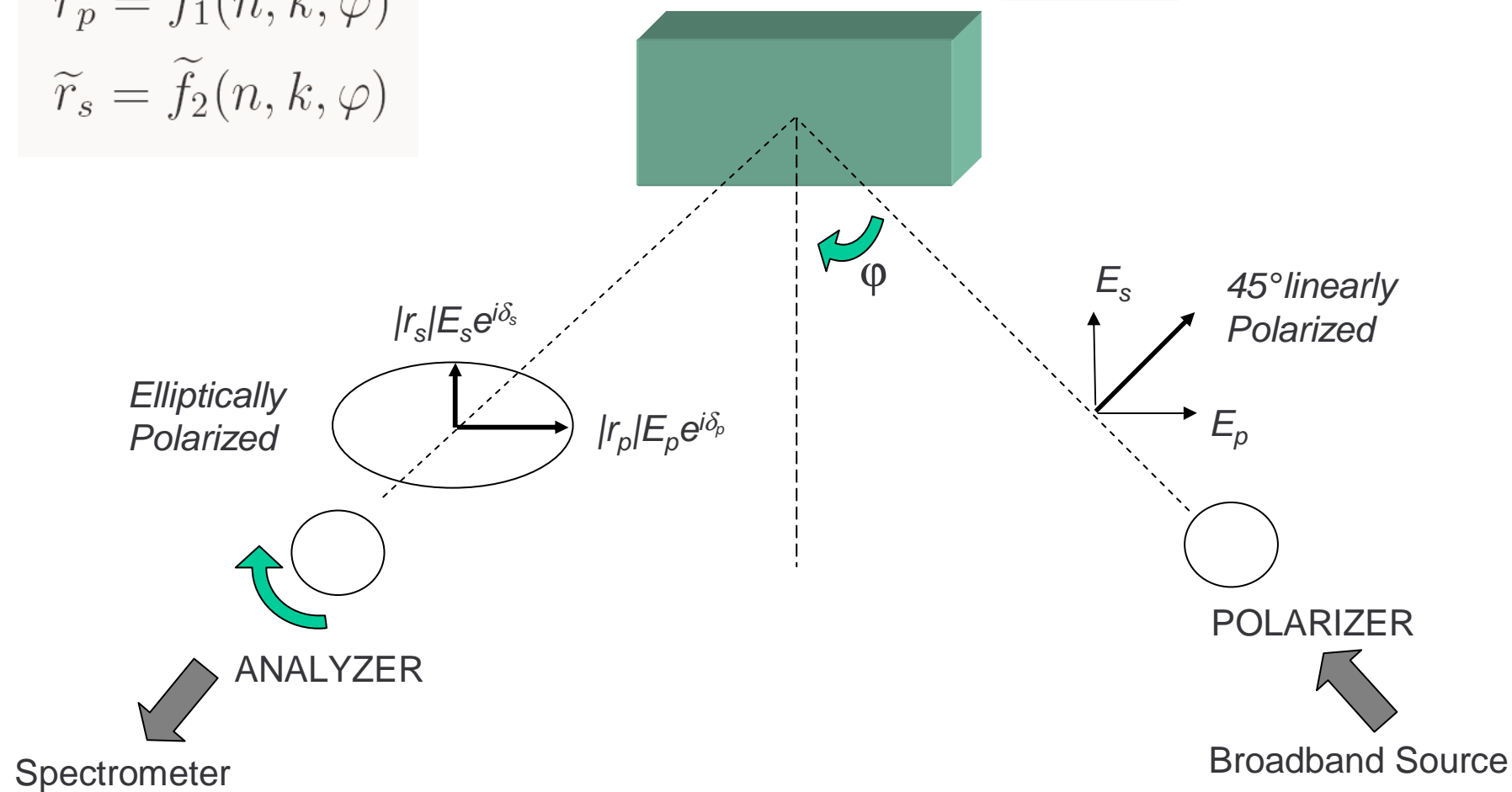
Fresnel formulae

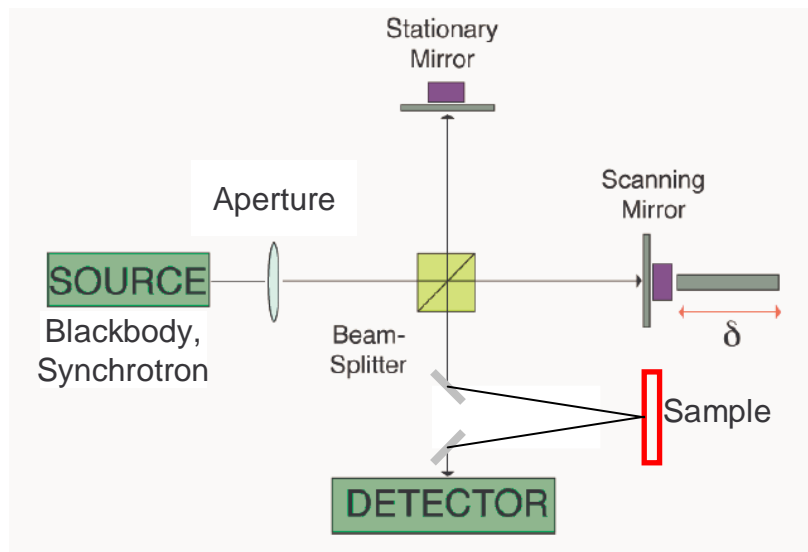
$$\tilde{r}_p = \tilde{f}_1(n, k, \varphi)$$

$$\tilde{r}_s = \tilde{f}_2(n, k, \varphi)$$

Material under analysis

$$n + ik$$

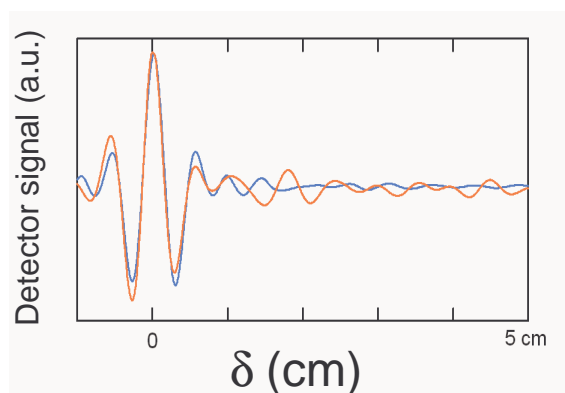




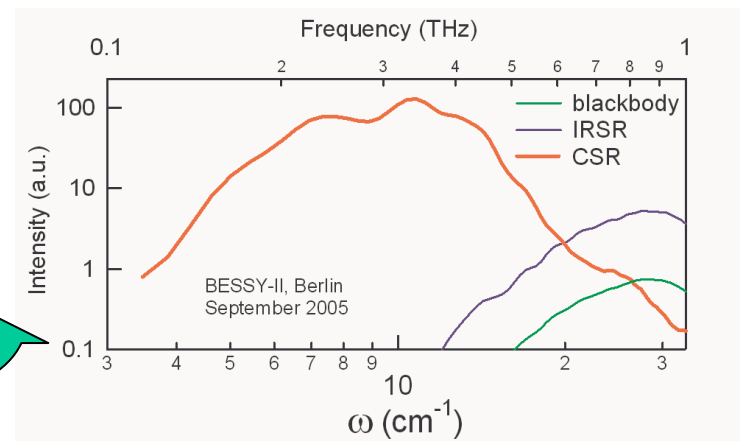
Infrared spectrometer: Michelson Interferometer

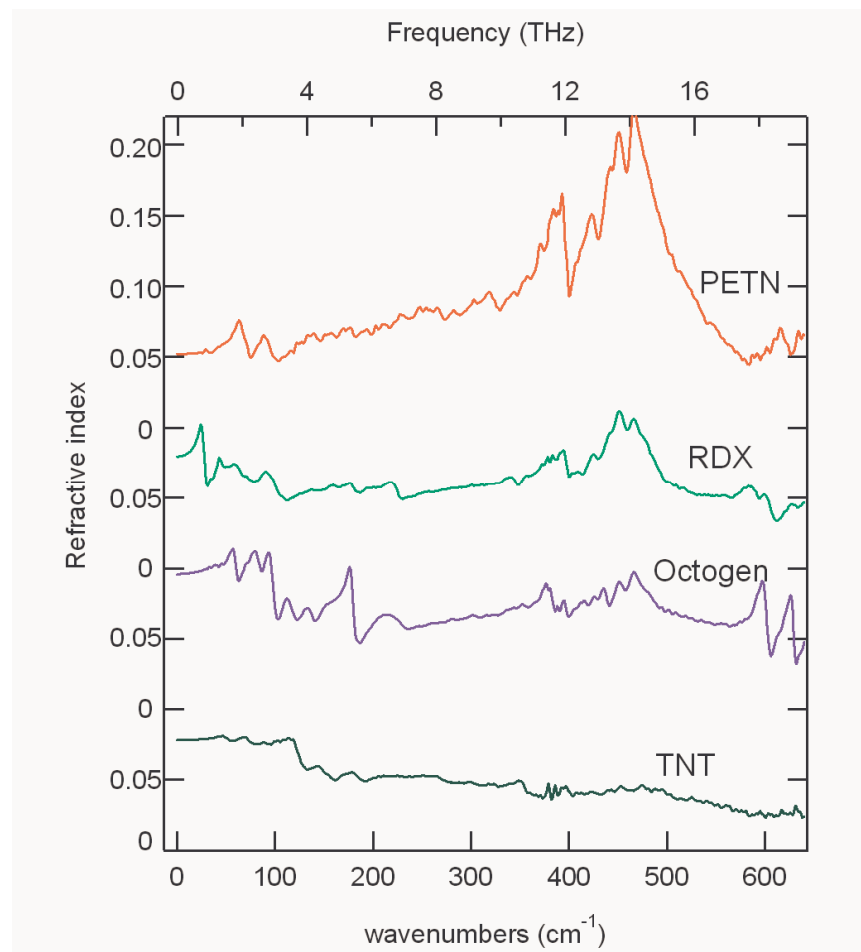
- Reflected and/or Transmitted Power spectra are measured as a function of the frequency ω
- Optical constants are derived by Kramers-Kronig analysis or by Ellipsometry

Frequency range: 0.1 THz – 2 PHz
Energy resolution: up to 0.01 THz



FFT





▪ Far-Infrared spectra

“Fingerprint” region: each solid substance has a specific spectrum, or frequency-dependent optical constants
(like a spectrometer)

▪ Terahertz frequencies

Clothes, tissues, plastic, paper and atmosphere are partly transparent: remote identification is possible
(like a radar)

Applications:

⇒ Remote security controls

⇒ Explosive detection

Fresnel relations: transcendental

$$\left. \begin{aligned} \tilde{r}_p &= \frac{(n+ik) \cos(\varphi) - \cos(\varphi')}{(n+ik) \cos(\varphi) + \cos(\varphi')} = |\tilde{r}_p| e^{i\delta_p} \\ \tilde{r}_s &= \frac{\cos(\varphi) - (n+ik) \cos(\varphi')}{\cos(\varphi) + (n+ik) \cos(\varphi')} = |\tilde{r}_s| e^{i\delta_s} \\ \sin(\varphi) &= (n+ik) \sin(\varphi') \end{aligned} \right\} \rightarrow n + ik$$

Michelson: intrinsic beam polarization!

$$\tilde{\rho} = \frac{\tilde{r}_p}{\tilde{r}_s} = \frac{(n+ik) \cos(\varphi) - \cos(\varphi')}{\cos(\varphi) - (n+ik) \cos(\varphi')} = \tan \Psi e^{i\Delta}$$

$$\tan \Psi = \frac{|\tilde{r}_p|}{|\tilde{r}_s|} \quad \Delta = \delta_p - \delta_s$$

Infrared ellipsometry requires calibration !

Normalized Stokes parameters calc with Mueller matrixes

$$\cos 2\Psi$$

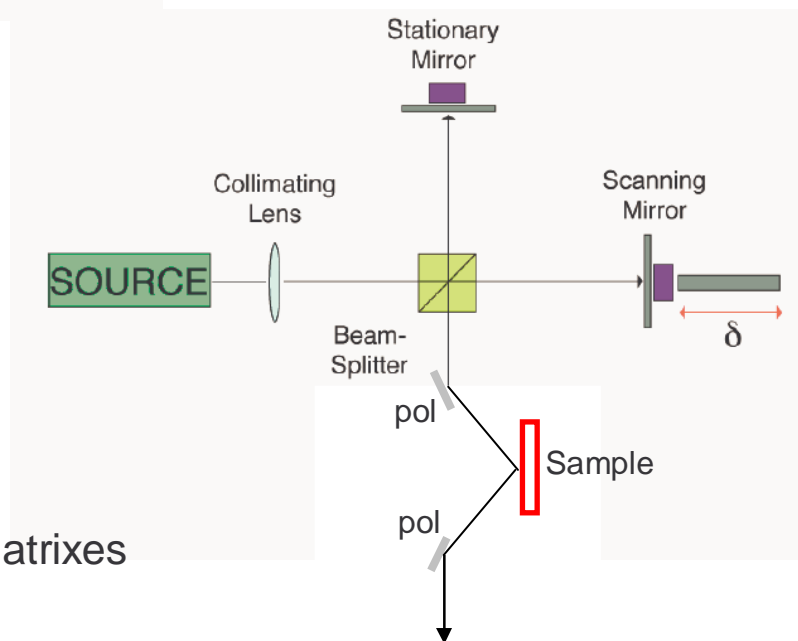
$$\sin 2\Psi \cos \Delta$$

$$\sin 2\Psi \sin \Delta$$

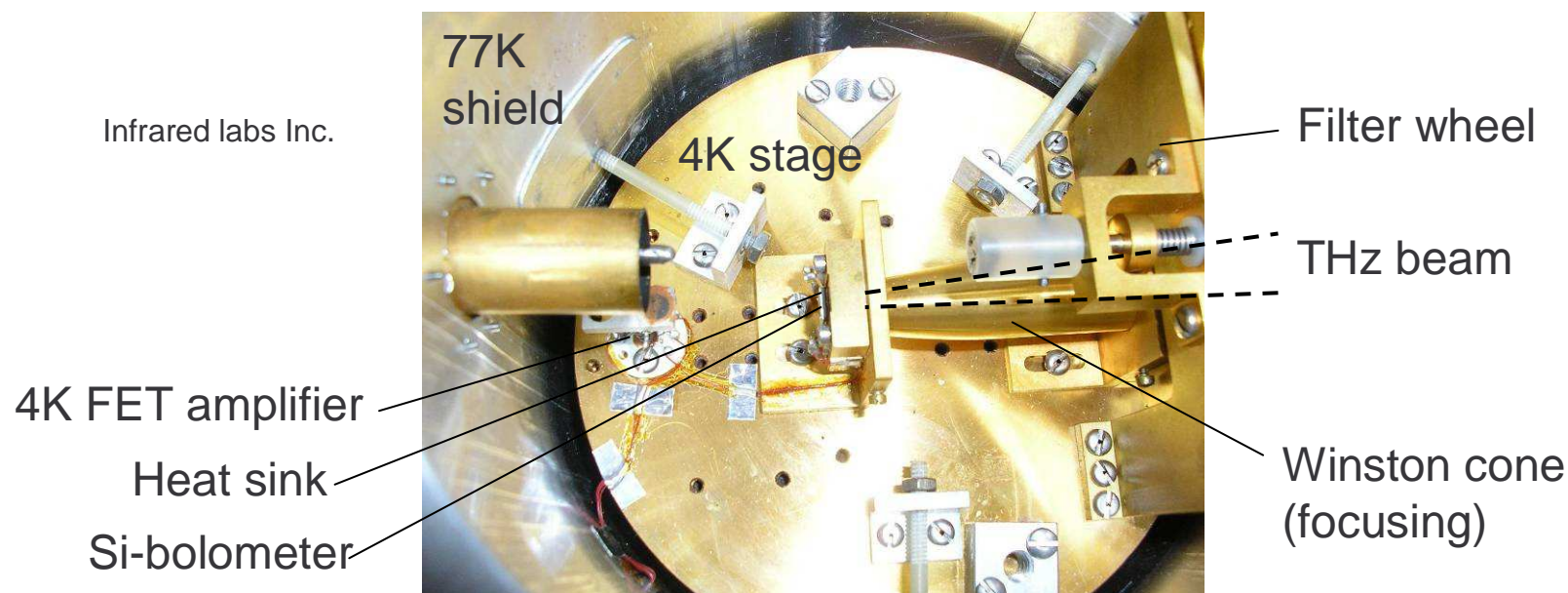


$$n + ik$$

in the whole infrared range!



Detector: Liquid Helium-cooled Bolometer



- Room-temperature detectors (Pyroelectrics, Golay cells) are also available, but noise figures are 10^3 times higher
- Development of sensitive detectors working at higher temperatures is ongoing (e.g. closed-cycle cooled, liquid nitrogen).
- CNR-IFN in Rome is developing superconducting bolometers.



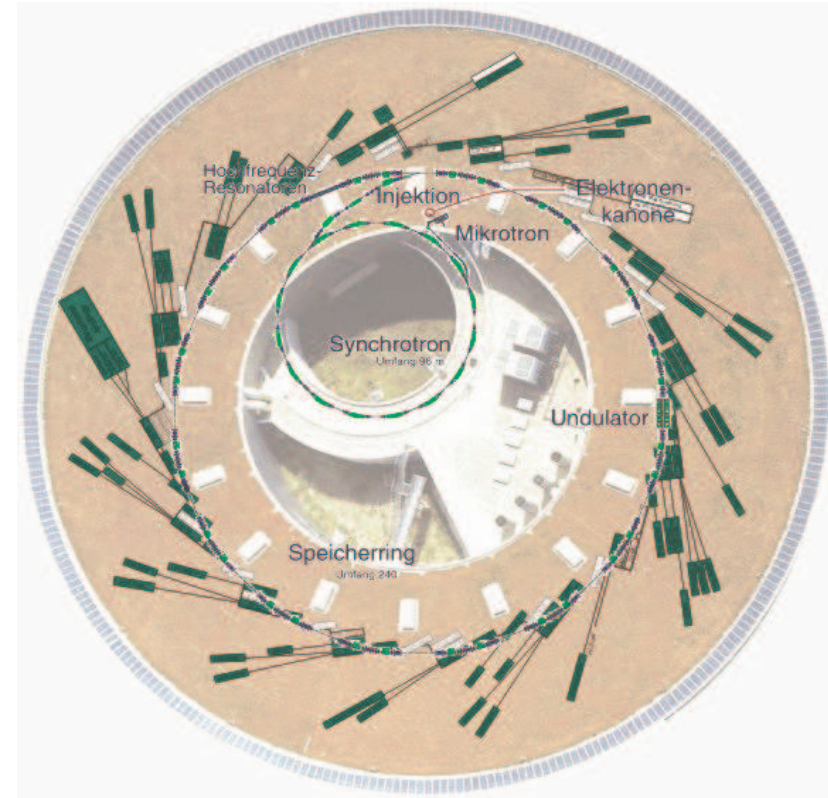
Source: Synchrotron BESSY in Berlin



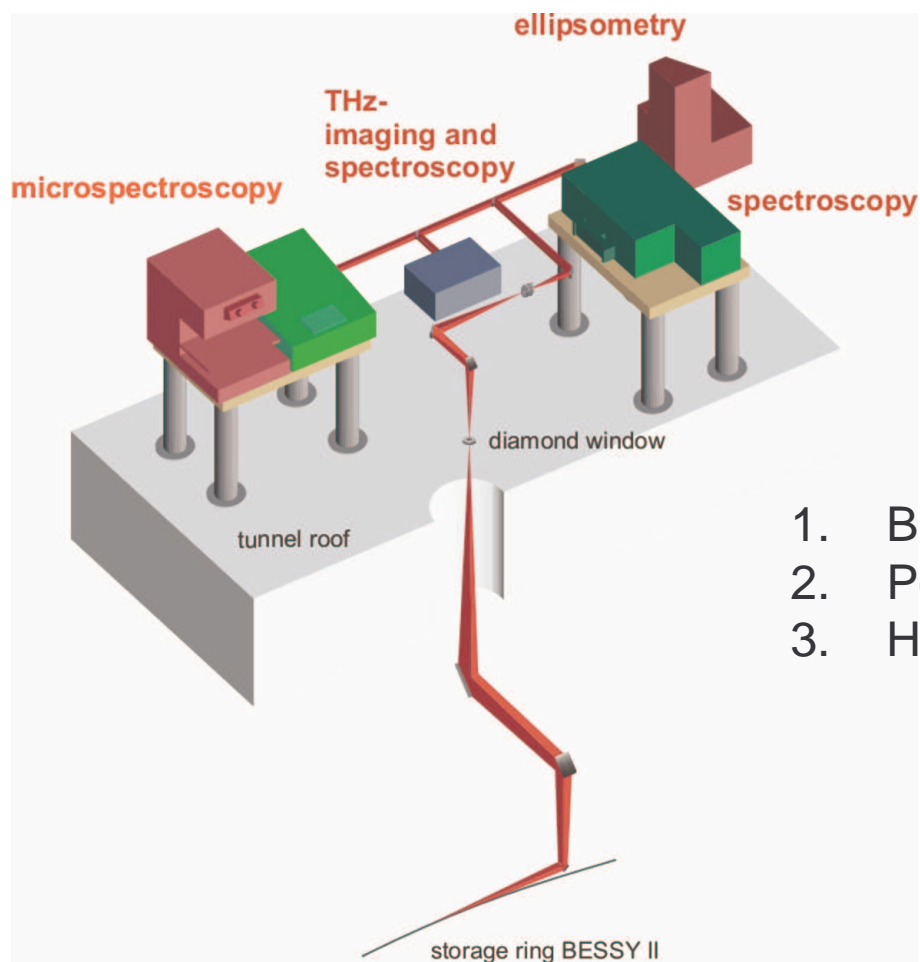
Start user operation:	1999
Circumference of the synchrotron:	96 m
Circumference of the storage ring:	240 m
Number of bending dipoles:	2 x 16
Number of possible insertion devices:	15
Number of beamlines commissioned:	~ 50

Commissioning of the IR-beamline IRIS: 2002

It is the only storage ring producing steady-state Coherent Synchrotron Radiation
=> high power, pulsed source in the 0.1-1 THz range based on electron bunch acceleration



The Infrared beamline at BESSY

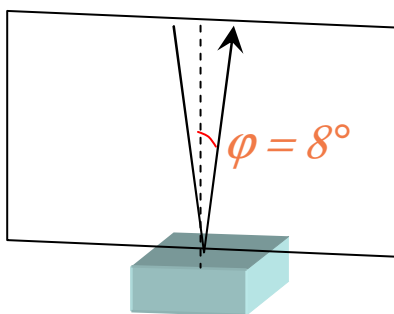


1. Broadband spectrum (MMW to UV)
2. Point-like source (tight focus)
3. High brilliance (photon density at focus)

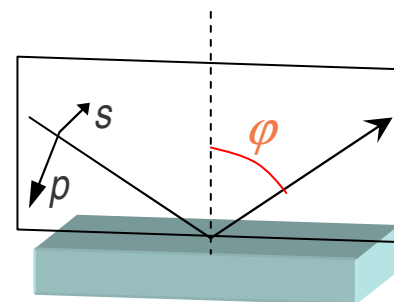


Far-infrared Ellipsometry

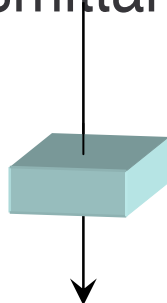
- Normal Incidence Reflectance



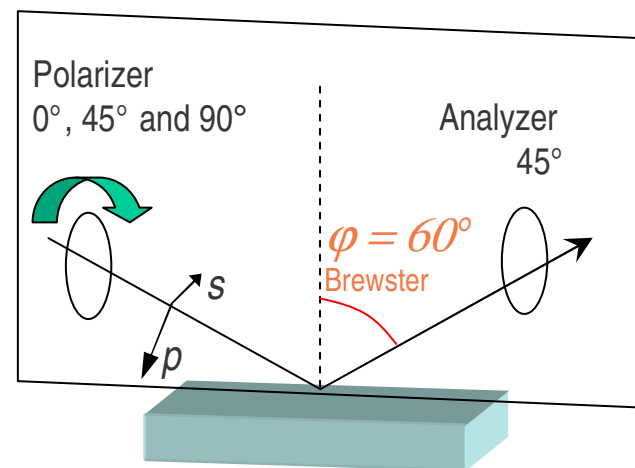
- Variable Angle Reflectance



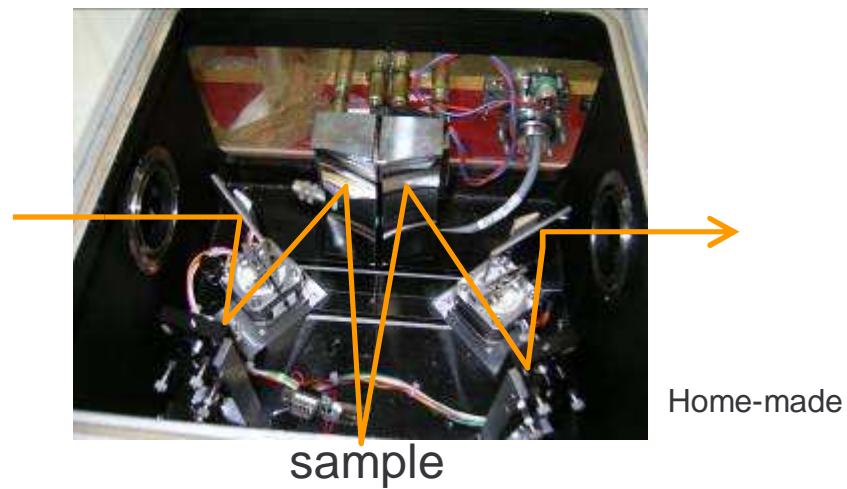
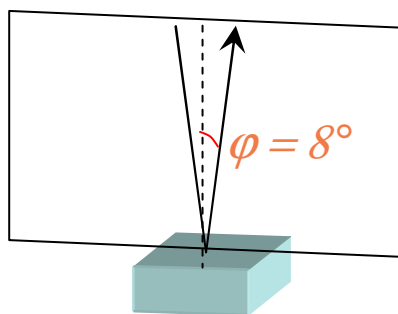
- Transmittance



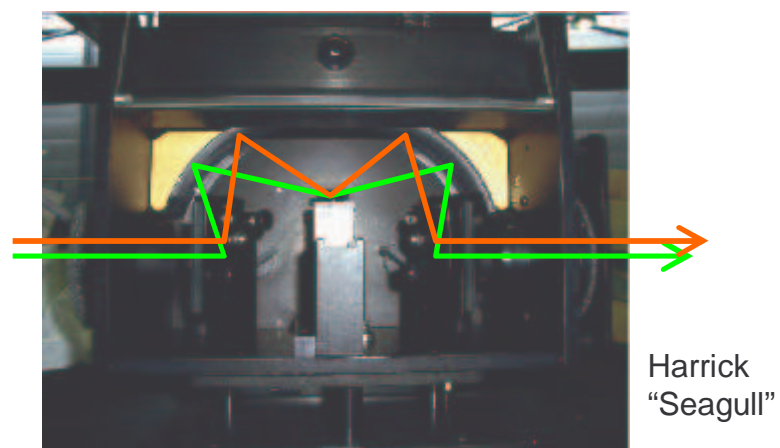
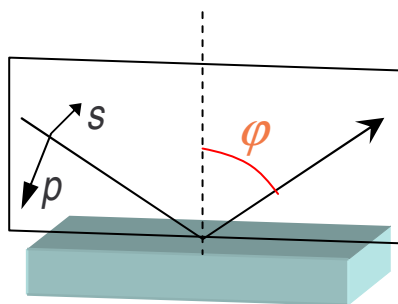
- Ellipsometry



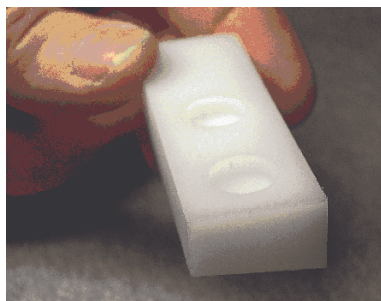
- Normal Incidence



- Variable Angle



Transmission of pure pellets of explosives and Oxygen-reducing salts

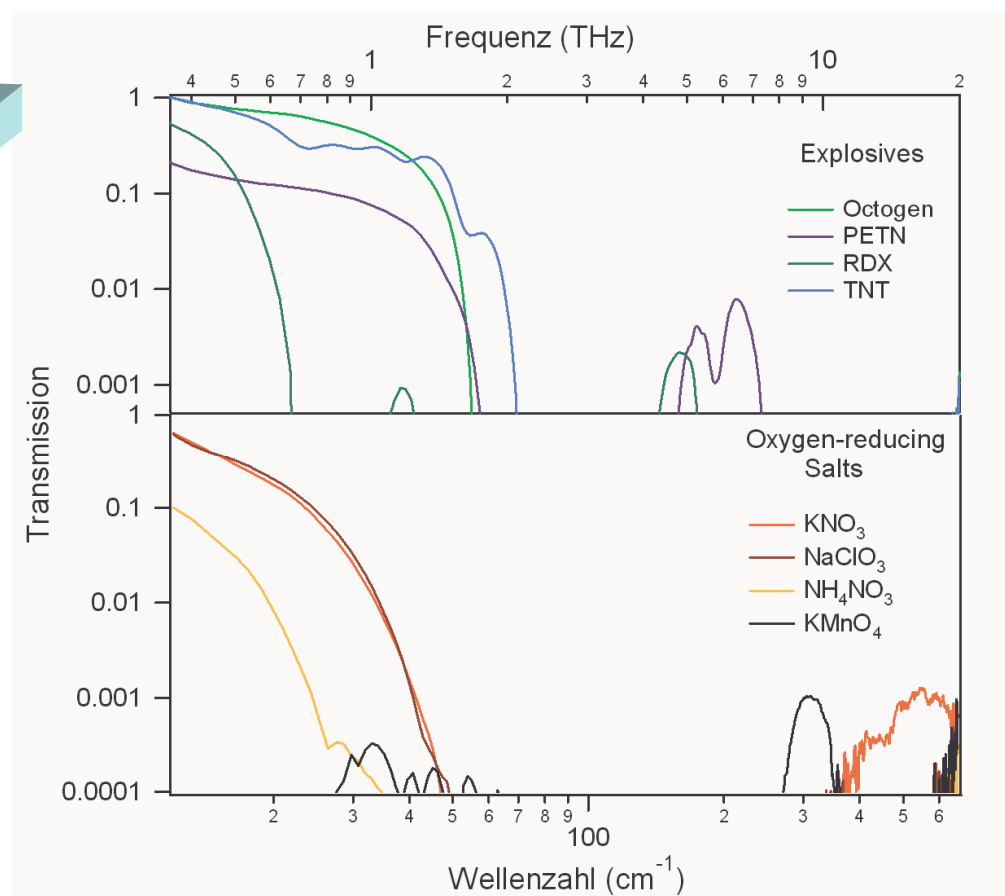
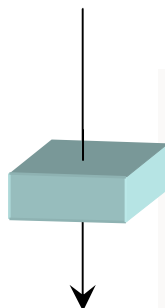


Pure Material pellets
Thickness: 2.0 mm

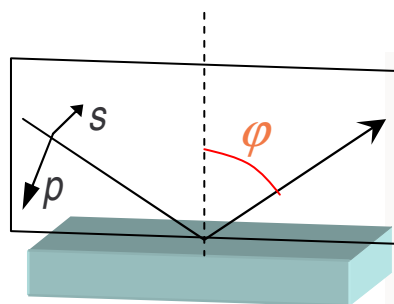
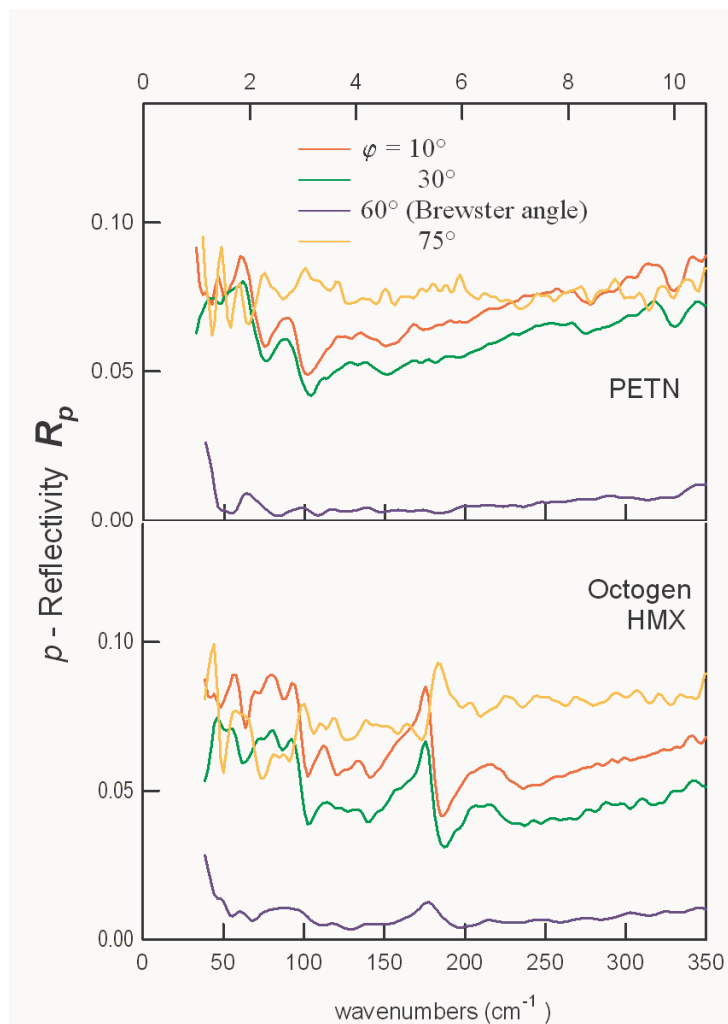
Bulk Polyethylene sample
holder, 15° wedged

High Transparency only
below 1 THz

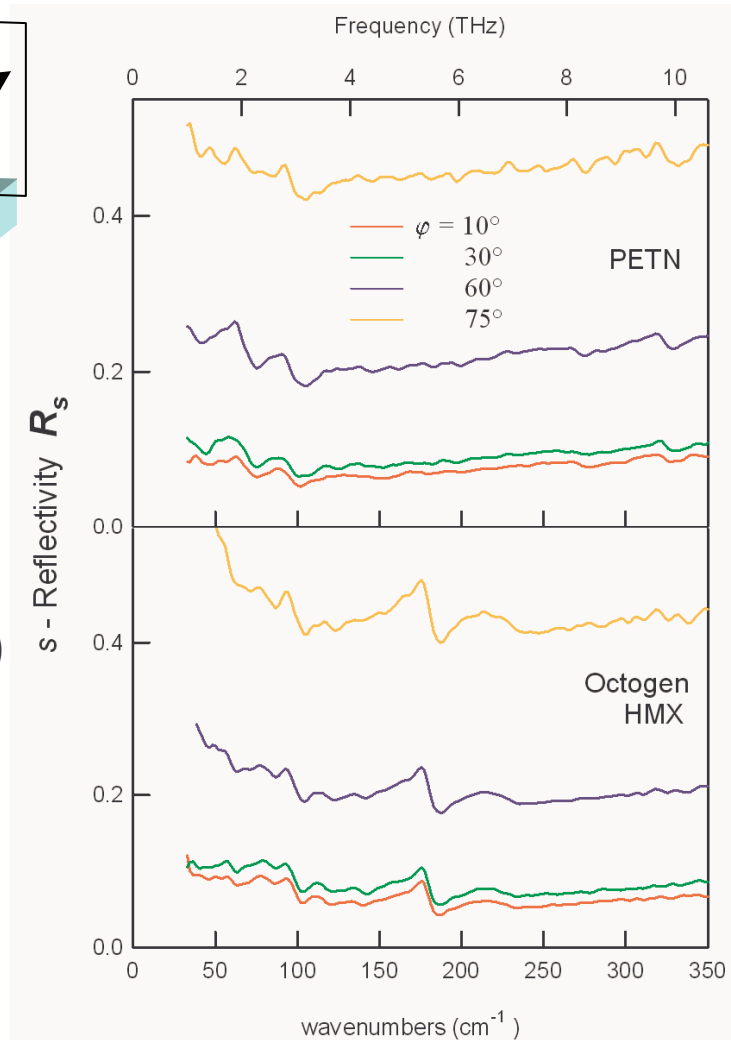
⇒ No strong material-
specific features



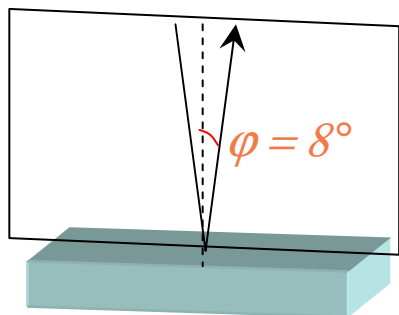
Absolute Reflectivity of pure explosive pellets for different angles of incidence



- Reference is a gold mirror
- $R_s \sim R_p$ for $\varphi \sim 0$,
 $R_s > R_p$ anywhere else
- R_p goes to 0 at the Brewster angle ($\sim 60^\circ$)
- The slope and the sharp features are material-specific and do not depend much on φ



Optical constants of explosives: Absolute Reflectivity and Kramers-Kronig analysis



KK

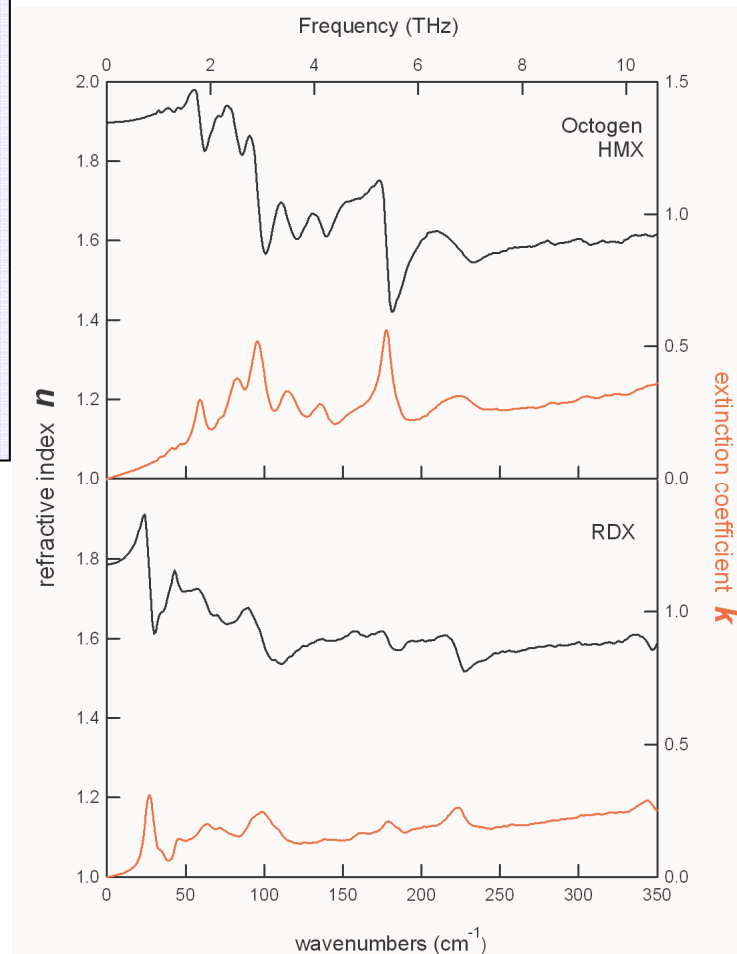
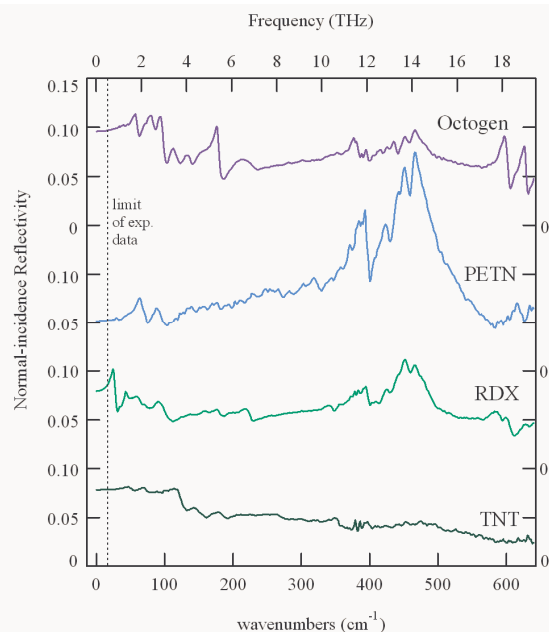
$$\phi_r(\omega) = -\frac{2\omega}{\pi} \mathcal{P} \int_0^\infty \frac{\ln \sqrt{R(\omega')}}{\omega'^2 - \omega^2} d\omega'$$

Absolute reflectivity R is measured at quasi-normal incidence from 0.7 to 20 THz to correctly evaluate the integral.

$$= Re^{i\phi} \\ = n + ik$$

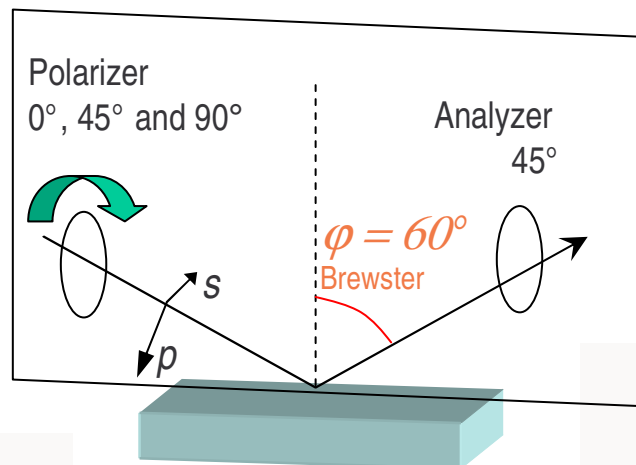
$$\tilde{n} = \frac{1 + \tilde{r}}{1 - \tilde{r}}$$

- High signal intensity
- Practical geometry
- High output quality
- Need a reference measurement on a mirror
- Very sensitive to absolute value (acceptable: $\pm 5\%$)
- Need for a databank of high frequency extrapolations

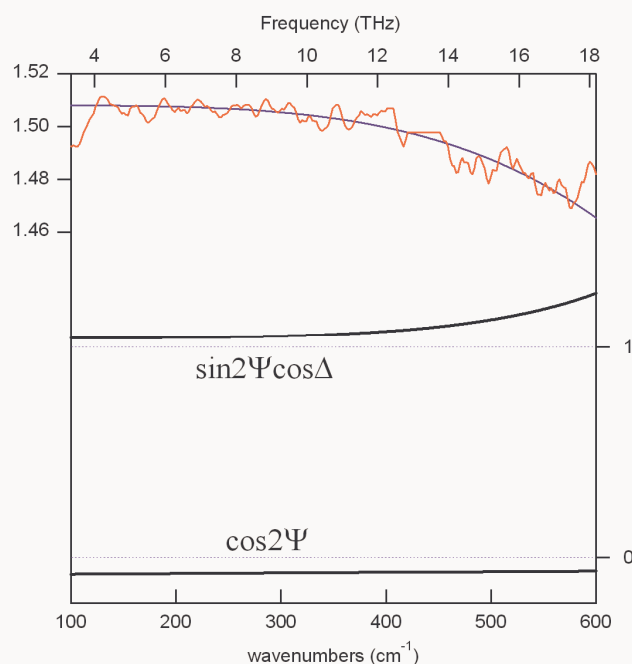


Spectroscopic Ellipsometry: optical constants with no reference measurement

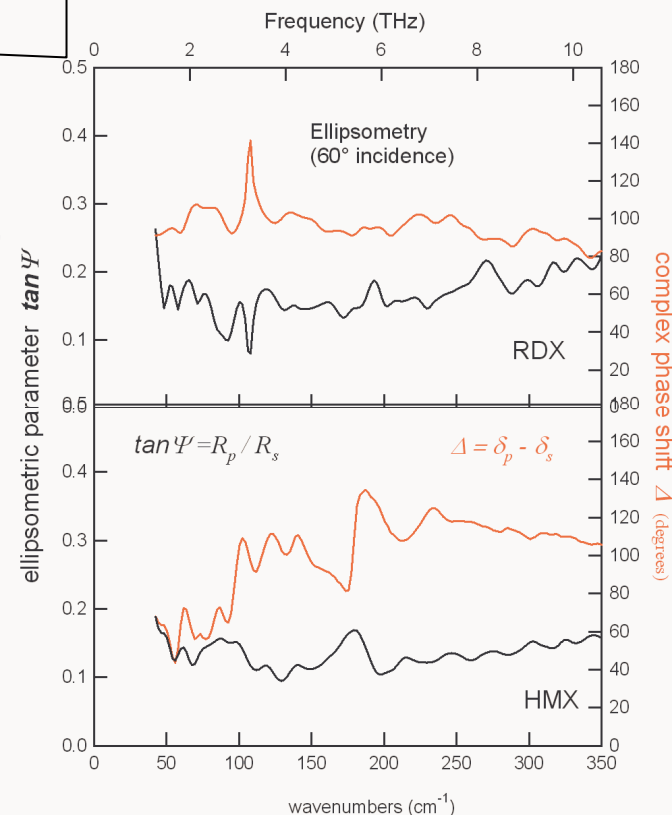
Calibration: a known, non-absorbing material at his Brewster angle, where the ellipse is most excentric



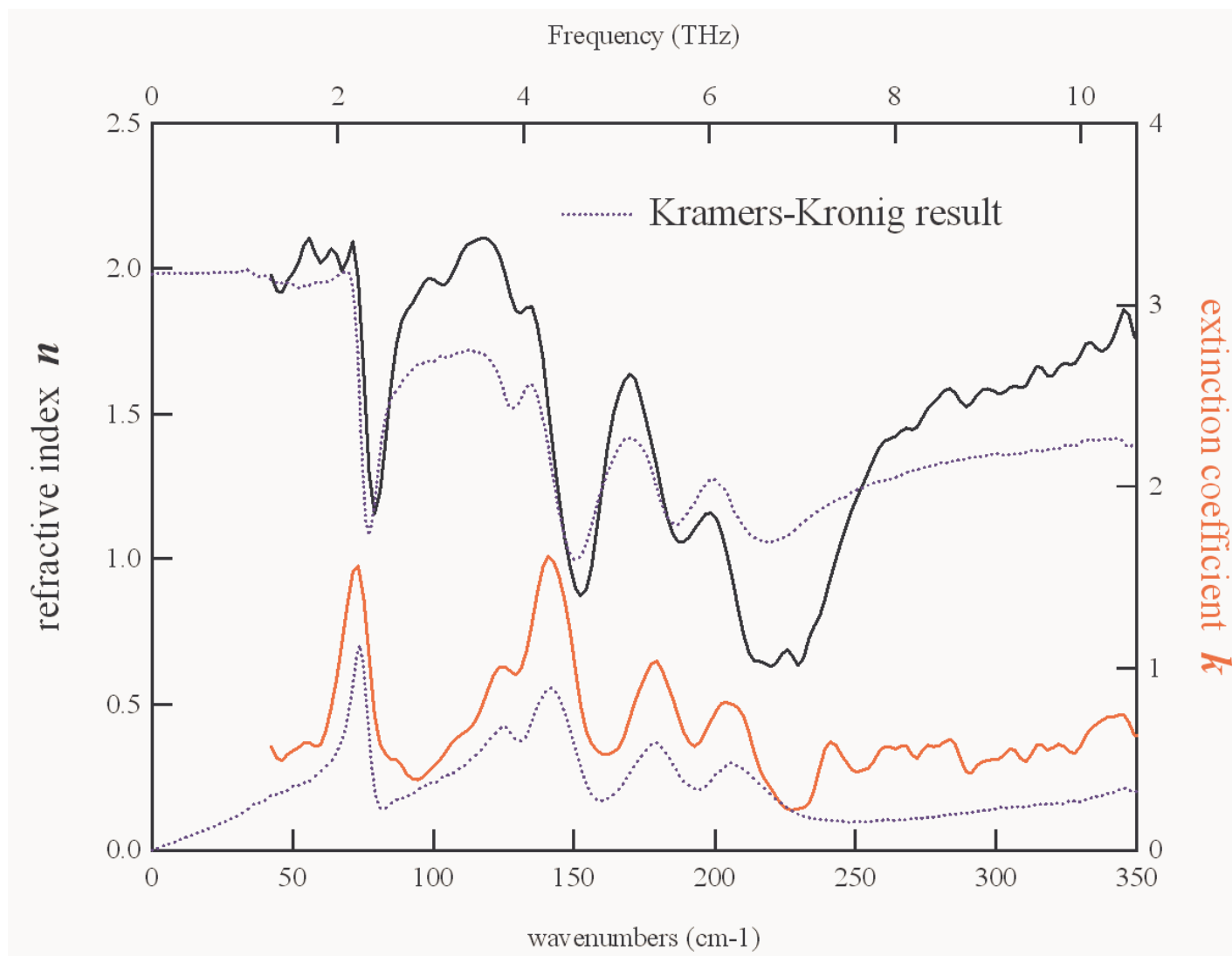
Data harvest: close to Brewster angle
Polarizer rotated instead of analyzer (equivalent)



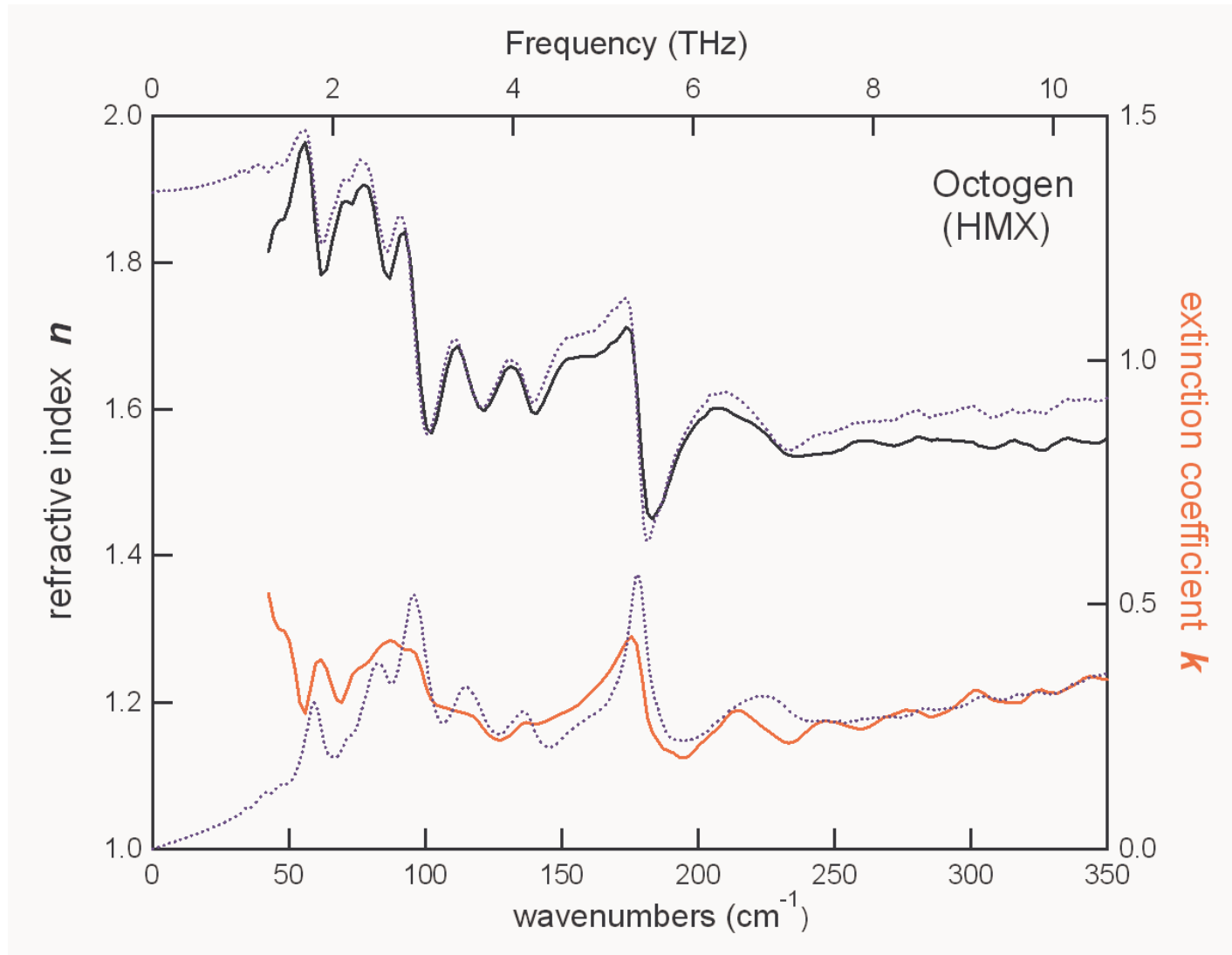
- n , k or Ψ , Δ determined from 3 sample spectra only (no mirror)
- the incidence angle has to be large ($>50^\circ$) and known ($\pm 0.5^\circ$)
- High sensitivity to noise (trigonometric functions)
- Low signal at low frequency (2 polarizers + 60° incidence)



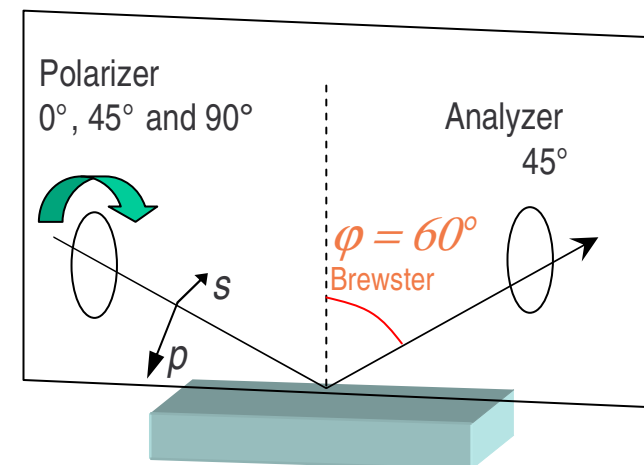
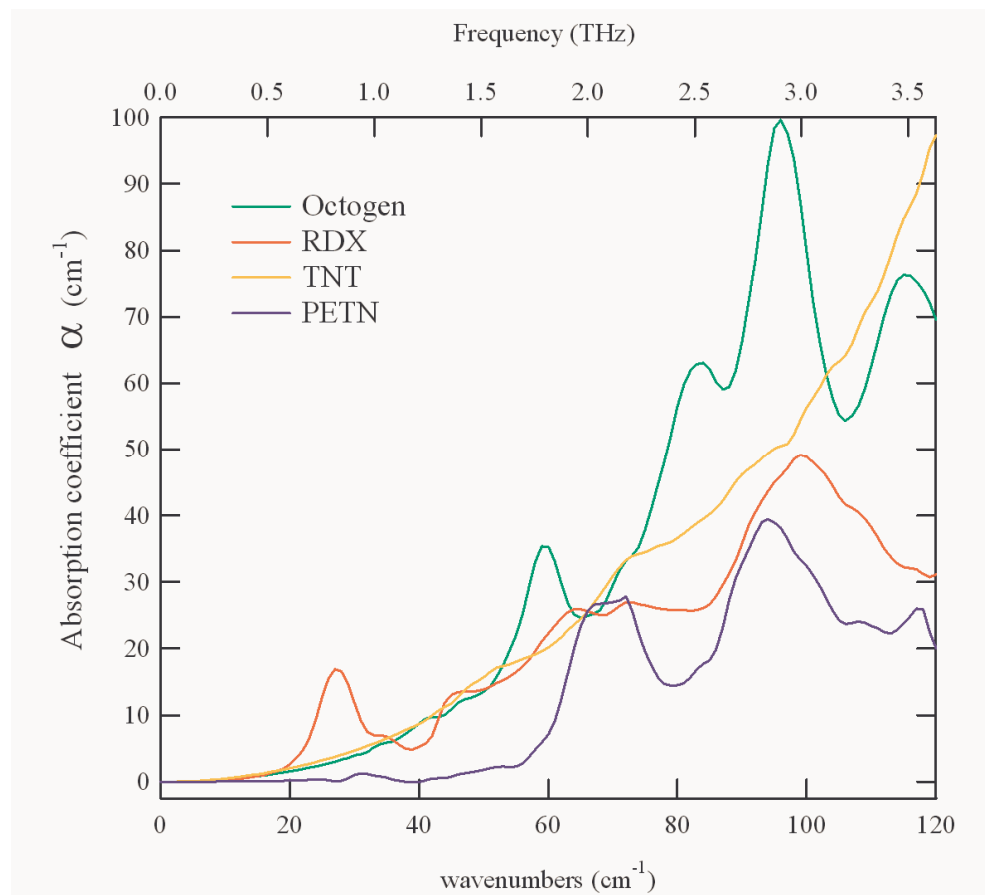
Result 1: NaClO₃ (a salt)



Result 2: Octogen (an explosive)



Absorption coefficient of explosives in the THz range



Optical constants determined by Far-infrared ellipsometry

⇒ No need for reference measurements to correct for the frequency-dependent incident power

⇒ Up to 4 THz, no role of surface roughness (common-use objects are “shiny”)